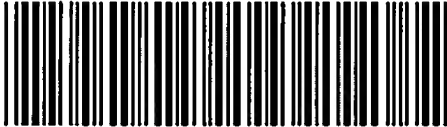


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/019,193	CHATELIER ET AL.	
	Examiner	Art Unit	
	Annan Q. Shang	2623	

SEARCHED			
Class	Subclass	Date	Examiner
725	44,46-50,68,139,151	4/3/2006	A.S
348	465,554	4/3/2006	A.S
348	725,731	4/3/2006	A.S

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR